## IN THE CLAIMS:

The following is a complete listing of the claims in this application, reflects all changes currently being made to the claims, and replaces all earlier versions and all earlier listings of the claims:

1. (original): A method of measuring performance parameters of an imaging device, said method comprising the steps of:

maintaining a test pattern image, said test pattern image comprising alignment features and image analysis features;

imaging a test chart using said imaging device to form a second image, said test chart containing a representation of said test pattern image;

registering said test pattern image and said second image using region based matching operating on said alignment features; and

measuring said performance parameters by analysing said image analysis features.

- 2. (previously presented): The method as claimed in claim 1, wherein said imaging device is a camera, and said test chart is a self-luminous device displaying said test pattern image.
- 3. (original): A method of measuring performance parameters of a printer, said method comprising the steps of:

maintaining a test pattern image, said test pattern image comprising alignment features and image analysis features;

printing said test pattern image using said printer to form a test chart;
imaging said test chart using a calibrated imaging device to form a second image;
registering said test pattern image and said second image using region based
matching operating on said alignment features; and

measuring said performance parameters by analysing said image analysis features.

- 4. (previously presented): The method as claimed in any one of claims 1 and 3, wherein different colour channels in said test pattern image and said second image are separately registered and analysed.
- 5. (previously presented): The method as claimed in any one of claims 1 and 3, wherein said region based matching uses overlapping blocks of image data from said test pattern image and said second image.
- 6. (previously presented): The method as claimed in any one of claims 1 and 3, wherein said analysis features are said alignment features.
- 7. (previously presented): The method as claimed in any one of claims 1 and 3, wherein said region based matching is block based correlation.
- 8. (previously presented): The method as claimed in any one of claims 1 and 3, wherein said registering step comprises the sub-steps of:

performing block based correlation on said test pattern image and said second image to determine a displacement map for mapping pixels of said test pattern image to corresponding pixels of said second image;

interpolating said displacement map to form a distortion map; and warping said test pattern image using said distortion map.

- 9. (previously presented): The method as claimed in any one of claims 1 and 3, wherein said measuring step includes comparing pixel values of corresponding pixels in said test pattern image and second image after said images have been registered.
- 10. (previously presented): The method as claimed in any one of claims 1 and 3, wherein said test pattern image is generated by the steps of:
  - (a) dividing an image area into a predetermined number of areas;
  - (b) dividing each of said areas into smaller areas;
- (c) within each area, assigning properties to at least one of said smaller areas, and designating the remainder of said smaller areas as areas;
- (d) generating pixel values for said at least one of said smaller areas, said pixel values being in accordance with said properties; and
  - (e) repeating steps (b) to (d).
- 11. (original): The method as claimed in claim 10, wherein said properties are randomized.

- 12. (previously presented): The method as claimed in claim 10, wherein said at least one of said smaller areas is selected randomly.
- 13. (previously presented): The method as claimed in claim 10, wherein said properties are one or more of:

colour;

slowly varying colour;

pattern with predetermined frequency distribution;

pattern with predetermined orientations; and

pseudo-random noise.

- 14. (previously presented): A method as claimed in claim 1, wherein said test pattern image is generated through the steps of:
  - (a) dividing an area into a predetermined number of smaller areas;
  - (b) selecting at least of said smaller areas;
- (c) generating pixel values for the selected smaller areas, said pixel values being in accordance with assigned properties;
  - (d) designating each of the unselected smaller areas as areas; and
  - (e) repeating steps (a) to (d) iteratively for each of the areas.
- 15. (original): The method as claimed in claim 14, wherein said properties are randomized.

16. (previously presented): The method as claimed in claim 14, wherein said at least one of said smaller areas is selected randomly.

17. (previously presented): The method as claimed in claim 14, wherein said properties are one or more of:

colour;

slowly varying colour;

pattern with predetermined frequency distribution;

pattern with predetermined orientations; and

pseudo-random noise.

18. (canceled).

19. (previously presented): The method as claimed in claim 10, wherein a test pattern corresponding to said test pattern image is a dyadic test pattern.

20. (original): Apparatus for measuring performance parameters of an imaging device, said apparatus comprising:

means for maintaining a test pattern image, said test pattern image comprising alignment features and image analysis features;

means for receiving a second image, said second image being an image captured by said imaging device of a test chart, and said test chart containing a representation of said test pattern image;

means for registering said test pattern image and said second image using region based matching operating on said alignment features; and

means for measuring said performance parameters by analysing said image analysis features.

21. (original): Apparatus for measuring performance parameters of a printer, said apparatus comprising:

means for maintaining a test pattern image, said test pattern image comprising alignment features and image analysis features;

said printer for printing said test pattern image to form a test chart;

a calibrated imaging device for imaging said test chart to form a second image;

means for registering said test pattern image and said second image using region

based matching operating on said alignment features; and

means for measuring said performance parameters by analysing said image analysis features.

22. (previously presented): Apparatus as claimed in claim 20 wherein said means for maintaining a test pattern image comprises:

means for dividing an area into a predetermined number of smaller areas;

means for selecting at least one of said smaller areas;

means for generating pixel values for the selected smaller areas, said pixel values being in accordance with assigned properties;

means for designating each of the unselected smaller areas as areas; and

means for iteratively passing control to said means for dividing, said means for selecting, said means for generating pixel values, and said means for designating.

## 23. (canceled).

24. (currently amended): A <u>non-transitory</u> computer\_readable medium storing a computer program for measuring performance parameters of an imaging device, said computer program when executed on a computing device <u>performs-performing</u> the steps of:

maintaining a test pattern image, said test pattern image comprising alignment features and image analysis features;

imaging a test chart using said imaging device to form a second image, said test chart containing a representation of said test pattern image;

registering said test pattern image and said second image using region based matching operating on said alignment features; and

measuring said performance parameters by analysing said image analysis features.

25. (currently amended): A <u>non-transitory</u> computer\_readable medium storing a computer program for measuring performance parameters of a printer, said computer program when executed on a computing device <u>performs-performing</u> the steps of:

maintaining a test pattern image, said test pattern image comprising alignment features and image analysis features;

printing said test pattern image using said printer to form a test chart;

imaging said test chart using a calibrated imaging device to form a second image; registering said test pattern image and said second image using region based matching operating on said alignment features; and

measuring said performance parameters by analysing said image analysis features.

26. (currently amended): A <u>non-transitory</u> computer\_readable medium as claimed in claim 24, wherein said test pattern image is generated through the steps of:

- (a) dividing an image area into a predetermined number of smaller areas;
- (b) selecting at least one of said smaller areas;
- (c) generating pixel values for the selected smaller areas, said pixel values being in accordance with assigned properties;
  - (d) designating each of the unselected smaller areas as areas; and
  - (e) repeating steps (a) to (d) iteratively for each of the areas.

27. - 33. (canceled).